


<b>Search Notes</b>  	<b>Application/Control No.</b>  10814286	<b>Applicant(s)/Patent Under Reexamination</b>  IM, HEUNG-JAE
	<b>Examiner</b>  Emmanuel Bayard	<b>Art Unit</b>  2611

SEARCHED			
Class	Subclass	Date	Examiner
375	136, 137, 142, 144, 147, 148, 150	12/6/2008	EB

SEARCH NOTES		
Search Notes	Date	Examiner
East	12/6/2008	EB

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
375	142, 148, 150	12/6/2008	EB

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